Ultrafast Hopping Dynamics of $5f$ Electrons in the Mott Insulator $UO₂$ Studied by Femtosecond Pump-Probe Spectroscopy

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We describe a femtosecond pump-probe study of ultrafast hopping dynamics of 5f electrons in the Mott insulator $UO₂$ following Mott-gap excitation at temperatures of 5–300 K. Hopping-induced response of the lattice and electrons is probed by transient reflectivity at mid- and above-gap photon energies, respectively. These measurements show an instantaneous hop, subsequent picosecond lattice deformation, followed by acoustic phonon emission and microsecond relaxation. Temperature-dependent studies indicate that the slow relaxation results from Hubbard excitons formed by $U^{3+} - U^{5+}$ pairs.

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Because of its important role as nuclear fuel, uranium dioxide $(UO₂)$ has been extensively studied for several decades, with intensive experimental [\[1](#page-3-1)] and computational [[2](#page-3-2)[–5](#page-3-3)] efforts on its material properties. It is known that the $5f$ electrons in UO₂ play a critical role in understanding its thermodynamic, electronic, and magnetic properties, but their Coulomb correlations have been elusive. Before recognition of the strong correlation between $5f$ electrons, investigations indicated that $UO₂$ was a magnetic semiconductor [[1](#page-3-1)], as opposed to a Mott insulator, as revealed by improved spectroscopic techniques [\[6–](#page-3-4)[8](#page-3-5)] and theoretical modeling [\[2](#page-3-2)[,9](#page-3-6)]. Femtosecond (fs) pump-probe spectroscopy permits the study of ultrafast dynamics of correlated electrons. Understanding such dynamics in cubic structured $UO₂$ should clarify the nature of 5f electrons and provide insight into the origin of superconductivity in heavy fermion U compounds [[10](#page-3-7)] and quantum correlation physics in ultracold atoms [\[11\]](#page-3-8).

In $UO₂$ the strong correlation characterized by the large on-site Coulomb repulsion of \sim 3 eV [\[12,](#page-3-9)[13\]](#page-3-10) splits a 5*f* band into a lower and an upper Hubbard band (LHB and UHB) [[14](#page-3-11)] and forms a Mott gap (optical gap of \sim 2 eV [\[1,](#page-3-1)[15\]](#page-3-12)). In the ground state, the LHB is occupied and the UHB empty, and two electrons are localized on each U site to form a highly ionic $U^{4+}(5f^2)$. Low-energy excitations across the Mott gap are therefore of intersite 5f-5f hopping character. The excitation creates a U^{3+} and U^{5+} pair:

$$
2U^{4+}(5f^2) \to U^{3+}(5f^3) + U^{5+}(5f^1), \tag{1}
$$

which may form either a bound state, such as a Hubbard exciton [[16](#page-3-13),[17](#page-3-14)], or remain decoupled, depending on the competition between Coulomb energy and kinetic energy. If lattice deformation is induced around U^{3+} and $U^{\bar{5}+}$, polarons or polaronic excitons may form [\[12](#page-3-9)[,18\]](#page-3-15).

Here we present a fs pump-probe study of hopping dynamics of $5f$ electrons in $UO₂$, in which a pump pulse at 3 eV initiates intersite hopping of 5f electrons, and a time-delayed pulse, at either 1.5 or 3 eV, probes the evolution of the lattice or excited electrons, respectively. We perform transient reflectivity measurements over a temperature (T) range of 5–300 K with emphasis on the antiferromagnetic (AFM) transition at the Néel temperature of $T_N = 30.8 \text{ K}$ [[1](#page-3-1)]. We observe an instantaneous response for intersite hopping of 5f electrons, followed by a picosecond (ps) response for lattice deformation, acoustic phonon emission, and its long-lived propagation in the sample. We find a slow relaxation process on microsecond (μs) time scales and assign it to the decay of Hubbard excitons formed by neighboring $U^{3+} - U^{5+}$ pairs.

The experiment was carried out with a 250-kHz Ti: sapphire regenerative amplifier producing 6 μ J, 80 fs pulses at 1.5 eV. The 3-eV pulses were generated by frequency doubling the fundamental for pumping or probing above the Mott gap. The pump fluence (F) ranged from 0.5–70 μ J/cm² and the probe, ~13 μ J/cm². Transient reflectivity was measured by varying the time delay between the pump and probe pulses when spatially overlapped on the sample. The fractional change of the probe reflectivity, $\Delta R/R$, was detected by a photodiode and then fed into a lock-in amplifier for high sensitivity measurements. The pump and probe pulses were S/P cross polarized to suppress noise from scattering. The sample was a 1-mm-thick, (100) surface-oriented single crystal of $UO₂$ mounted in a liquid He cooled cryostat for measurements at low temperatures.

Figure [1](#page-1-0) shows the measured 1.5-eV reflectivity transients, $\Delta R/R$, of UO₂ at several different temperatures for a fixed pump fluence $F = 64 \mu J/cm^2$ as a function of the time delay *t* between the pump and probe pulses. Each transient contains three stages: the initial 60 ps revealing the detailed rise process plus the first oscillation cycle, up to 0.9 ns showing damped oscillations, and 27–28 ns showing persistent relaxation after a long delay. Negative transients indicate photoinduced absorption. The initial ps rise appears to be an exponential with an amplitude, A_0 , initially offset from zero by A_{off} , and a time constant, τ_{rise} , as

$$
\Delta R/R = A_0 - (A_0 - A_{\text{off}})e^{-t/\tau_{\text{rise}}}.
$$
 (2)

FIG. 1 (color online). Measured 1.5-eV reflectivity transients of $UO₂$ at different temperatures. Smooth lines are exponential fits for the rise time, τ_{rise} , and the fast relaxation time, τ_{fast} , at a temperature $T = 7$ K.

The relaxation can be represented by the sum of three terms: both fast and slow decaying exponentials, and a damped oscillation, with respective time constants, τ_{fast} , τ_{slow} , and τ_{osc} , as

$$
\Delta R/R = A_1 e^{-t/\tau_{\text{fast}}} + A_2 e^{-t/\tau_{\text{slow}}} + A_{\text{osc}} e^{-t/\tau_{\text{osc}}} \cos(2\pi ft - \delta).
$$
 (3)

Here A_n are the component amplitudes, f the oscillation frequency, and δ the phase.

The oscillation term in Eq. ([3\)](#page-1-1) exhibits a frequency of 29.4 GHz consistent with $f = 2nv/\lambda$ where $n = 2.31$ and $v = 5294$ m/s at 300 K [\[1](#page-3-1),[19](#page-3-16)], corresponding to an acoustic phonon packet propagating into the sample [[4](#page-3-17),[20](#page-3-18)]. Here n and κ are, respectively, the real and imaginary parts of the refractive index at the probe wavelength λ and ν , the speed of sound. The observed $A_{\rm osc}$ and f vary negligibly with T. The near normal incidence reflectivity, $R(T)$, was measured and found to be decreasing linearly from 16% to 13.5% between 300 and 5 K, resulting in a decrease in $n(T)$ and an increase in $v(T)$ of $\sim 7.4\%$, which means that the lattice becomes less flexible at lower T. The continuity of $v(T)$ likely indicates the absence of structural phase transitions in unexcited $UO₂$, such as Jahn-Teller distortions [\[21\]](#page-3-19). The observed large $\tau_{\rm osc} = \lambda/4\pi v\kappa$ of ~ 0.3 ns and small $\delta \approx \kappa/n$ of ~ 0 [[20](#page-3-18)] confirm that the probe is well below the Mott gap for the entire T range.

The left panel of Fig. [2](#page-1-2) shows the T dependence of the rise amplitude, A_0 , and the rise and relaxation time constants, τ_{rise} , τ_{fast} , and τ_{slow} , which are extracted from the fits of the measured 1.5-eV reflectivity transients at a fixed

FIG. 2 (color online). Left panel: Temperature dependence of the rise amplitude, A_0 , and time constants, τ_{rise} , τ_{fast} , and τ_{slow} , at a pump fluence $F = 64 \mu J/cm^2$, extracted from 1.5-eV reflectivity transients. Right panel: Fluence dependence of the above parameters and the oscillation amplitude, A_{osc} , at a temperature $T = 7$ K. A linear fit of $A_0(F)$ and a $1/T^{1/2}$ curve fit of $\tau_{\text{rise}}(T)$ are included. Error bars are added for τ_{slow} .

pump fluence $F = 64 \mu J/cm^2$ $F = 64 \mu J/cm^2$ using Eqs. (2) and ([3\)](#page-1-1). The right panel of Fig. [2](#page-1-2) shows the F dependence of the above parameters and the oscillation amplitude, A_{osc} , at a fixed $T = 7$ K. All T-dependent parameters increase upon cooling except for an anomaly of τ_{fast} around T_N . For the F -dependent parameters, τ_{rise} decreases but all others increase with increasing F.

The behavior of the rise amplitude, A_0 , is understood in terms of photoinduced midgap states. The absorbed pump energy into $UO₂$ thermalizes the 5 f electron subsystem to an elevated electronic temperature T_e within 80 fs, while the lattice stays at the ambient temperature T. During τ_{rise} , excited electrons dissipate energy into the lattice and cause lattice deformation around U^{3+} and U^{5+} , which then generates transient midgap states. The maximum density of the midgap states is reached at the largest deformation, resulting in the rise amplitude, A_0 , presumably proportional to $T_e - T$. The observed large amplitude increase of $A_0(T)$ on cooling is due to a slower decrease of T_e . The measured $A_0(F)$ fits as a straight line at lower F but quickly deviates from linearity at higher F , indicating that 1.5-eV photons probe hopping-induced lattice effects.

The T and F dependences of the characteristic rise and relaxation times reflect lattice dynamics and electron correlation. A longer $\tau_{\text{rise}}(T)$ at lower T means more time is needed for electron-lattice thermalization when the lattice

is rigid. $\tau_{\text{rise}}(T)$ can be fit as $1/T^{1/2}$ $1/T^{1/2}$ $1/T^{1/2}$, as shown in Fig. 2, which describes the T-dependent trend of the hopping duration of a polaron [[12](#page-3-9)], indicative of the time for lattice distortion. The fast relaxation time $\tau_{\text{fast}}(T)$ results from the expanding of lattice distortion into the unexcited $UO₂$ during 100 ps timeframes, as the distortion amplitude following excitation decreases exponentially along the sample depth. The anomalous drop of $\tau_{\text{fast}}(T)$ around T_N indicates the restoration of AFM correlation (the spinlattice relaxation) following the lattice disturbance. When thermal excitation is nearly quenched at $T = 7$ K, a shorter $\tau_{\text{rise}}(F)$ at higher F means less time with more energy for lattice deformation, and a longer $\tau_{\text{fast}}(F)$ or $\tau_{\text{slow}}(F)$ at higher F means more excitonic states and more interaction among them. Persistent oscillations at low F indicate strong coupling between hopping electrons and the lattice.

A nonzero offset, represented by A_{off} in Eq. [\(2\)](#page-0-0), of $\Delta R/R$ at zero time delay $t = 0$, is apparent in Fig. [1](#page-1-0) at low T, meaning that the prior pump pulse (4 μ s ahead) contributes to a residual ΔR . If we assume an exponential decay for $\Delta R/R$, we can calculate τ_{slow} using the transient data at $t = 0.8$ ns and $t = 4$ μ s. At high T, A_{off} falls to zero or into noise levels because of limited sensitivity. Additionally, we add an extra time delay of 27 ns and then calculate τ_{slow} using the transient data at $t = 0.8$ ns and $t = 27$ ns. Remarkably, we find that τ_{slow} is on μ s time scales, as shown in Fig. [2,](#page-1-2) much longer than ps to ns relaxation times observed on 3d transition metal oxides [[22](#page-3-20)].

To directly probe the behavior of photoexcited 5f electrons in the UHB, we change the probe photon to 3 eV but use the same pump energy of 3 eV. Figure [3](#page-2-0) shows the measured 3-eV reflectivity transients, $\Delta R/R$, of UO₂ at several different temperatures for a fixed pump fluence $F = 64 \mu J/cm^2$. Oscillations in the transients are barely observable because of absorption of the probe within a 100 nm skin depth [[1](#page-3-1)]. An average of six transients at $T = 295$ K is shown in the inset of Fig. [3.](#page-2-0) The halffrequency of the oscillations confirms the presence of acoustic phonons represented in Eq. ([3](#page-1-1)). The small damping constant and large phase of the oscillations result from a large imaginary part (κ) of the refractive index.

The initial relaxation stage of the 3-eV reflectivity transients is fit to a decaying exponential with an amplitude, A_{flat} , and a time constant, τ_{relax} . The slow relaxation time appears shorter than those probed by 1.5-eV photons but still occurs on μ s time scales. All transients show an abrupt, positive rise, indicating that the electron hop happens within 80 fs (the pulse duration or time resolution). The transients fall into a flat region of the amplitude, A_{flat} , during τ_{relax} . When $T < T_N$, τ_{relax} actually includes two stages: a relaxation towards zero and a rise towards a negative maximum, but we treat it as a single relaxation term for simplicity. The T dependence of A_{flat} and τ_{relax} at $F = 64 \mu J/cm^2$ are plotted in the left panel of Fig. [4,](#page-2-1) and the F dependence of them at $T = 7$ K are in the right

FIG. 3 (color online). Measured 3-eV reflectivity transients of $UO₂$ at different temperatures. Inset: An average of six transient scans and a fit of damped oscillations at 295 K. The smooth line on $T = 295$ K is an exponential fit for the initial relaxation time, τ_{relax} , and the flat amplitude, A_{flat} .

panel. $A_{\text{flat}}(F)$ fits linearly over a larger F range than for the 1.5-eV probe, because the number of excited 5f electrons is proportional to F. $\tau_{\text{relax}}(T)$ decreases on lowering T , but $\tau_{\text{relax}}(F)$ does not exhibit monotonic behavior. $A_{\text{flat}}(F)$ does not cross zero, but $A_{\text{flat}}(T)=0$ at T_N ,

FIG. 4 (color online). Left panel: Temperature dependence of the flat amplitude, A_{flat} , and the initial relaxation time, τ_{relax} , at a pump fluence $F = 64 \mu J/cm^2$, extracted from 3-eV reflectivity transients. Right panel: Fluence dependence of the parameters at a temperature $T = 7$ K. A linear fit of $A_{flat}(F)$ is included. Error bars are added for τ_{relax} .

suggesting that $A_{\text{flat}}(T)$ intrinsically characterizes the magnetic order.

The T and F dependences of τ_{slow} in Fig. [2](#page-1-2) suggest the formation of Hubbard excitons during the relaxation. Analogous to one-dimensional extended Hubbard models [\[16\]](#page-3-13), the Hubbard model in the fcc lattice of U^{4+} can be considered to contain neighbor Coulomb interactions, and thus allows Hubbard excitons [[16](#page-3-13),[17](#page-3-14)] of bound pairs of nearest-neighbor U^{3+} and U^{5+} , written as $U^{3+} - U^{5+}$. Unbound U^{3+} and U^{5+} pairs may also be created following excitation. They should have a recombination time strongly dependent on the initial number of pairs (or F), but the observed $\tau_{slow}(F)$ at 7 K is very flat. The result indicates that the μ s relaxation time arises from bound pairs only and that the pairing occurs during the initial relaxation time of τ_{relax} . In the noncollinear 3-k AFM structure of $UO₂$ [\[5](#page-3-3),[23](#page-3-21)], the magnetic moments of nearest neighbors U^{4+} form a relative angle of 109 $^{\circ}$, which hinders the hopping of an excited electron to its nearest neighbor because a spin-flip is involved and thus slows down the recombination of a bound pair $U^{3+} - U^{5+}$. When $T > T_N$, thermal motion assists the spin-flip and breaks the binding of U^{3+} and U^{5+} , resulting in a quick drop of the observed relaxation time $\tau_{\text{slow}}(T)$.

The observed zero crossing of $A_{flat}(T)$ at T_N and the decrease of $\tau_{relax}(T)$ at low T in Fig. [4](#page-2-1) follow as a consequence of Hubbard excitons in UO₂. When $T>T_N$, excited 5f electrons in the UHB are free to hop to neighboring sites, similar to itinerant carriers in semiconductors as seen by optical conductivity, and thus, contribute a $\Delta R > 0$. When $T \leq T_N$, 5f electrons are depleted because they form excitons, resulting in a fast drop in conductivity and thus $\Delta R < 0$. The observation that $\tau_{\text{relax}}(T)$ appears flat when $T>T_N$ but decreases rapidly when $T < T_N$ is explained by the hypothesis that the magnetic pairing of U^{3+} and U^{5+} overwhelms the intra-UHB relaxation where $\tau_{\text{relax}}(T)$ is an interplay of the two processes. The apparent maximum of $\tau_{\text{relax}}(F)$ supports such a scenario of competing processes.

Our results show that the hopping of $5f$ electrons in $UO₂$ happens in less than 80 fs, but is followed by an intra-UHB relaxation, simultaneous lattice deformation, and if $T < T_N$, the binding of $U^{3+} - U^{5+}$, all on ps time scales. The intersite hopping induces strong electron-lattice interaction as indicated by coherent acoustic phonon emission over a wide range of temperatures and excitation levels. The relaxation is found to be unusually slow, on μ s time scales, and is attributed to Hubbard excitons of $U^{3+} - U^{5+}$ pairs. The behavior of the transient reflectivity around T_N shows that the pairing of $U^{3+} - U^{5+}$ is mediated through magnetic ordering, a signature of Hubbard excitons.

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